Search Notes



Application/Control No.

10578762

Examiner

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Applicant(s)/Patent Under Reexamination

TAN ET AL.

Art Unit

4138

SEARCHED						
Class		Subclass	Date	Examiner		
433	10-11		10.24.2006	НМВ		

SEARCH NOTES	3	
Search Notes	Date	Examiner
W/ Wilson on above search	10.24.2007	HMB

INTERFERENCE SEARCH							
Class	Subclass	Date	Examiner				

U.S. Patent and Trademark Office Part of Paper No.: 20071024